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Declaration under Rule 4.17:

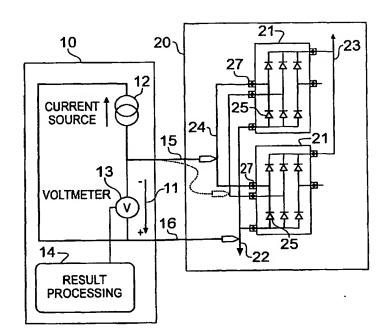
 as to the applicant's entitlement to claim the priority of the earlier application (Rule 4.17(iii)) for all designations

Published:

- with international search report
- before the expiration of the time limit for amending the claims and to be republished in the event of receipt of amendments

[Continued on next page]

(54) Title: A METHOD OF AND APPARATUS FOR TESTING FOR INTEGRATED CIRCUIT CONTACT DEFECTS



(57) Abstract: Various tester configurations are provided that injects test signals into nets (e.g. 24). Non-linear characteristics of the response are detected (e.g. harmonics, do offset) and used to assess the adequacy or otherwise of device connections in the net.

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For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

INTERNATIONAL SEARCH REPORT

mational Application No . T/GB 03/04640

A. CLASSIF	CATION OF SUB	JECT MATTER
TPC 7	CATION OF SUB G01R31/0	4 GO1R27/20

C DOCUMENTS CONSIDERED TO BE RELEVANT

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (dassification system followed by classification symbols) IPC 7 GO1R

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

EPO-Internal, WPI Data, PAJ, INSPEC, IBM-TDB

Category °	Citation of document, with indication, where appropriate, of the	relevant passages Relevant to claim No.
X	US 5 365 180 A (EDELMAN RAN) 15 November 1994 (1994-11-15)	1,4,5, 10-15, 18,19, 22,23, 28-32, 35-37
Υ	column 1, line 15 - line 20	6-9,16, 17, 24-27,34
	column 2, line 5 - line 27 column 3, line 4 - line 14 column 3, line 24 - line 57	
Α	figure 1 claim 1	2,3,20, 21,33
	·	-/
X Fur	ther documents are listed in the continuation of box C.	Patent family members are listed in annex.
"A" docum	categories of cited documents: nent defining the general state of the art which is not idered to be of particular relevance	*T* tater document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
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P docum	r means nent published prior to the International filing date but than the priority date claimed	ments, such combination being obvious to a person skilled in the art. "&" document member of the same patent family
	e actual completion of the international search 21 October 2004	Date of mailing of the international search report Ö. 5. 11. 2004
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national Application No. T/GB 03/04640

	ation) DOCUMENTS CONSIDERED TO BE RELEVANT Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
Category *	Citation of document, with indication, where appropriate, or the recevant passages	Televan to canific.
A	EP 0 622 733 A (SGS THOMSON MICROELECTRONICS) 2 November 1994 (1994-11-02) abstract column 2, line 15 - line 18 column 4, line 1 - line 17 claims 1,5,14 figure 5	10,28
A	US 5 786 700 A (JEN KEH-CHEE ET AL) 28 July 1998 (1998-07-28) abstract figures 2,3	10,28
Y	ROBINSON C ED - INSTITUTE OF ELECTRICAL AND ELECTRONICS ENGINEERS: "ANALOG AC HARMONIC METHOD FOR DETECTING SOLDER OPENS" PROCEEDINGS OF THE INTERNATIONAL TEST CONFERENCE. ITC '97. WASHINGTON, DC, NOV. 1 - 6, 1997, INTERNATIONAL TEST CONFERENCE, NEW YORK, NY: IEEE, US, vol. CONF. 28, 1 November 1997 (1997-11-01), pages 125-126, XP000800318 ISBN: 0-7803-4210-0 page 125, column 1, paragraph 1 - column 2, paragraph 2	6-9,16, 17, 24-27,34
A	MINOWA I ET AL: "Nonlinear distortion voltage testing of contact surfaces" CONFERENCE PROCEEDINGS ARTICLE, 26 September 1988 (1988-09-26), pages 277-280, XP010077325 page 277, column 1, paragraph 1	6

INTERNATIONAL SEARCH REPORT

International application No. PCT/GB 03/04640

Box I	Observations where certain claims were found unsearchable (Continuation of item 1 of first sheet)	_
This Int	emational Search Report has not been established in respect of certain claims under Article 17(2)(a) for the following reasons:	
1.	Claims Nos.: because they relate to subject matter not required to be searched by this Authority, namely:	
2.	Claims Nos.: because they relate to parts of the International Application that do not comply with the prescribed requirements to such an extent that no meaningful International Search can be carried out, specifically:	
3.	Claims Nos.: because they are dependent claims and are not drafted in accordance with the second and third sentences of Rule 6.4(a).	•
Box II	Observations where unity of invention is lacking (Continuation of item 2 of first sheet)	i
This int	ternational Searching Authority found multiple inventions in this international application, as follows:	
	see additional sheet	
1. X	As all required additional search fees were timely paid by the applicant, this international Search Report covers all searchable claims.	
2.	As all searchable claims could be searched without effort justifying an additional fee, this Authority did not invite payment of any additional fee.	
3.	As only some of the required additional search fees were timely paid by the applicant, this International Search Report covers only those claims for which fees were paid, specifically claims Nos.:	
4.	No required additional search fees were timely paid by the applicant. Consequently, this International Search Report is restricted to the invention first mentioned in the claims; it is covered by claims Nos.:	
Remar	The additional search fees were accompanied by the applicant's protest. X No protest accompanied the payment of additional search fees.	

INTERNATIONAL SEARCH REPORT

FURTHER INFORMATION CONTINUED FROM PCT/ISA/ 210

This International Searching Authority found multiple (groups of) inventions in this international application, as follows:

1. claims: 1-5,10-15,18-23,28-33,35-37

Method of testing the integrity of connections including non-linear elements on the basis of an offset voltage of the dynamic resistance in the non-linear circuit.

2. claims: 6-9,16,17,24-27,34

AC harmonic analysis for detecting non-linear components on a net.

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etional Application No '/GB 03/04640

Patent document cited in search report		Publication date		Patent family member(s)	Publication date
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EP 0622733	A	02-11-1994	EP DE DE JP US	0622733 A1 69312263 D1 69312263 T2 7146327 A 5521511 A	02-11-1994 21-08-1997 30-10-1997 06-06-1995 28-05-1996
US 5786700	A	28-07-1998	NONE		